## SURFACE ROUGHNESS PROFILE PARAMETERS

| Parameter | Name |
| :--- | :--- |
| Ra | Roughness Average (Ra) |
| $\mathbf{R q}$ | Root Mean Square (RMS) Roughness |
| $\mathbf{R t}$ | Maximum Height of the Profile |
| $\mathbf{R v}, \mathbf{R m}$ | Maximum Profile Valley Depth |
| $\mathbf{R p}$ | Maximum Profile Peak Height |
| $\mathbf{R p m}$ | Average Maximum Profile Peak Height |
| $\mathbf{R z}$ | Average Maximum Height of the Profile |
| $\mathbf{R m a x}$ | Maximum Roughness Depth |
| $\mathbf{R c}$ | Mean Height of Profile Irregularities |
| $\mathbf{R z}$ (iso) | Roughness Height |
| $\mathbf{R y}$ | Maximum Height of the Profile |
| $\mathbf{W t ,} \mathbf{~ w}$ | Waviness Height |
| $\mathbf{S}$ | Mean Spacing of Local Peaks of the Profile |
| $\mathbf{S m , ~ R S m ~}$ | Mean Spacing of Profile Irregularities |
| $\mathbf{D}$ | Profile Peak Density |
| $\mathbf{P c}$ | Peak Count (Peak Density) |
| $\mathbf{H S C}$ | Hight Spot Count |
| $\lambda \mathbf{a}$ | Average Wavelength of the Profile |
| $\lambda \mathbf{q}$ | Root Mean Square (RMS) Wavelength of the Profile |
| $\Delta \mathbf{a}$ | Average Absolute Slope |
| $\Delta \mathbf{q}$ | Root Mean Square (RMS) Slope |
| Lo | Developed Profile Length |
| $\mathbf{I r}$ | Profile Length Ratio |
| $\mathbf{R s k , S k}$ | Skewness |

## Surface Finish Definitions:

1. Ra: Ra is the arithmetic average of the absolute values of the roughness profile ordinates. Also known as Arithmetic Average (AA), Center Line Average (CLA). The average roughness is the area between the roughness profile and its mean line, or the integral of the absolute value of the roughness profile height over the evaluation length
2. $R z: R z$ is the arithmetic mean value of the single roughness depths of consecutive sampling lengths. $Z$ is the sum of the height of the highest peaks and the lowest valley depth within a sampling length.
3. Cutoff $\lambda \mathbf{c}$ : of a profile filter determines which wavelengths belong to roughness and which ones to waviness.
4. Sampling Length: is the reference for roughness evaluation. Its length is equal to the cutoff wavelength.
5. Traversing Length: is the overall length traveled by the stylus when acquiring the traced profile. It is the total of Pretravel, evaluation length and post travel
6. Evaluation Length: is the part of the traversing length from where the values of the surface parameters are determined.
7. Pre-Travel: the first part of the traversing length.
8. Post-Travel: The last part of the traversing length

## Selection of Cutoff $\lambda \mathbf{c}$

| Profile |  | Cutoff | Sampling/Evaluation Length |
| :---: | :---: | :---: | :---: |
| Rz ( $\mu \mathrm{m}$ ) | $\mathbf{R a}(\mu \mathrm{m})$ | $\boldsymbol{\lambda c}$ (mm) | Ir / In (mm) |
| Up to . 1 | Up to . 02 | . 08 | . 08 / . 4 |
| Over. 1 up to .5 | Over .02 up to .1 | . 25 | . 25 / 1.25 |
| Over . 5 up to 10 | Over . 1 up top 2 | . 8 | . 8 / 4 |
| Over 10 up to 50 | Over 2 up to 10 | 2.5 | 2.5 / 12.5 |
| $\begin{aligned} & \text { Over } 50 \\ & \text { up to } 200 \end{aligned}$ | Over 10 up to 80 | 8 | $8 / 40$ |

